Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/597,908	CHIDA, TAISUKE
Examiner	Art Unit
Patricia T. Nguyen	2817

SEARCHED						
Cla	ss	Subclass	Date		Examiner	
33	0	9	1/3/2008		PN	
		260				
		301				
		85				
		97				
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INTERFERENCE SEARCHED						
Cla	ISS	Subclass	Da	te	Exan	niner
33	30	9	1/3/2008		PN	
		260				
		301				
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	SEARCH NOT (INCLUDING SEARCH)
		DATE	EXMR
EAST		1/3/2008	PN
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